

# CA3138, CA3138A

## High-Current, High-Beta N-P-N Transistor Arrays

For Industrial, Commercial, and Military Applications  
Four Isolated Discrete Sealed-Junction High-Current  
N-P-N Transistors

**Features:**

- High Current — 1 A
- High Beta — 95 min. at  $I_C = 500$  mA,  $V_{CE} = 5$  V
- Low  $V_{CE(SAT)}$  — 0.4 V max. at  $I_C = 500$  mA,  $I_B = 12.5$  mA
- Silicon Nitride Passivated
- Platinum Silicide Ohmic Contacts

The RCA-CA3138 and CA3138A are high-current n-p-n transistor arrays containing four isolated (discrete) sealed-junction high-current n-p-n transistors. They are intended for high-current, high-speed switching and driver applications.

The CA3138A has all the features and characteristics of the CA3138 but is intended for applications requiring premium grade specifications — higher rating for  $V_{CBO}$  of 25 volts and limits established for  $I_{CEO}$ ,  $I_{EBO}$ , and  $h_{FE}$  at 10 mA.

The CA3138 and CA3138A are supplied in a 14-lead dual-in-line plastic package and operate over the full military temperature range of  $-55^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ .

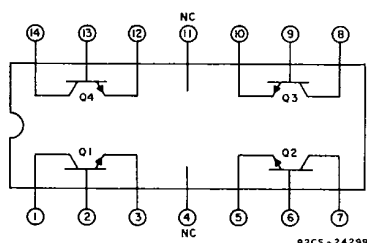


Fig. 1 — Terminal diagram (top view).

**Applications:**

- High-Current LED Driver
- Relay and Solenoid Driver
- Lamp Driver

**MAXIMUM RATINGS, Absolute-Maximum Values:**

COLLECTOR-TO-EMITTER VOLTAGE	15	V
With Base Open ( $V_{CEO}$ )		
COLLECTOR-TO-BASE VOLTAGE		
With Emitter Open ( $V_{CBO}$ )		
CA3138	20	V
CA3138A	25	V
EMITTER-TO-BASE VOLTAGE	5	V
With Collector Open ( $V_{EBO}$ )		
COLLECTOR CURRENT ( $I_C$ )	1	A
POWER DISSIPATION ( $P_D$ )		
At $T_A$ up to $25^{\circ}\text{C}$ :		
For Each Transistor	1	W
Total Package	2	W
At $T_A$ above $25^{\circ}\text{C}$ derate linearly		
	20	mW/ $^{\circ}\text{C}$
AMBIENT TEMPERATURE RANGE:		
Operating	$-55$ to $+125$	$^{\circ}\text{C}$
Storage	$-65$ to $+150$	$^{\circ}\text{C}$
LEAD TEMPERATURE (DURING SOLDERING):		
At distance $1/16 \pm 1/32$ inch ( $1.59 \pm 0.79$ mm) from case for 10 seconds max.		
	265	$^{\circ}\text{C}$

File Number 1131

## CA3138, CA3138A

ELECTRICAL CHARACTERISTICS at  $T_A = 25^\circ\text{C}$ 

Characteristic	Test Conditions	LIMITS						Units
		CA3138			CA3138A			
		Min.	Typ.	Max.	Min.	Typ.	Max.	
Collector-to-Emitter Sustaining Voltage, $V_{CE0(sus)}^*$	$I_C = 1\text{ mA}, I_B = 0$	15	20	—	15	20	—	V
Collector-to-Emitter Breakdown Voltage, $V_{(BR)CES}$	$I_C = 10\ \mu\text{A}$	20	55	—	25	60	—	V
Collector-to-Base Breakdown Voltage, $V_{(BR)CBO}$	$I_C = 10\ \mu\text{A}, I_E = 0$	20	55	—	25	60	—	V
Emitter-to-Base Breakdown Voltage, $V_{(BR)EBO}$	$I_E = 10\ \mu\text{A}, I_C = 0$	5	7.2	—	5	7.2	—	V
Base-to-Emitter Saturation Voltage, $V_{BE(sat)}^*$	$I_C = 500\text{ mA}, I_B = 12.5\text{ mA}$	0.7	0.81	1.1	0.7	0.81	1.1	V
Collector-to-Emitter Saturation Voltage, $V_{CE(sat)}^*$	$I_C = 500\text{ mA}, I_B = 12.5\text{ mA}$	—	0.26	0.4	—	0.26	0.4	V
Collector Cutoff Current	$I_{CBO}$ $V_{CB} = 15\text{ V}$	—	0.03	1	—	0.02	0.1	$\mu\text{A}$
	$I_{CEO}$ $V_{CE} = 10\text{ V}$	—	0.5	—	—	0.3	1.0	
	$I_{EBO}$ $V_{EB} = 4\text{ V}$	—	0.01	—	—	0.01	0.1	
Static Forward-Current Transfer Ratio (Beta), $h_{FE}^*$	$I_C = 10\text{ mA}, V_{CE} = 5\text{ V}$	—	—	—	35	140	—	
	$I_C = 100\text{ mA}, V_{CE} = 5\text{ V}$	80	160	450	80	160	450	
	$I_C = 500\text{ mA}, V_{CE} = 5\text{ V}$	95	170	500	95	170	500	
	$I_C = 1\text{ A}, V_{CE} = 5\text{ V}$	40	170	—	40	170	—	
Small-Signal Forward Current Transfer Ratio, $h_{fe}$	$I_C = 50\text{ mA}, V_{CE} = 10\text{ V}, f = 100\text{ MHz}$	2	—	—	2	—	—	
Collector-to-Base Capacitance, $C_{CB}$	$V_{CB} = 10\text{ V}, I_E = 0$	—	18	—	—	18	—	pF
Emitter-to-Base Capacitance, $C_{EB}$	$V_{EB} = 0.5\text{ V}, I_C = 0$	—	77	—	—	77	—	pF
Rise Time (See Test Ckt. Fig. 6), $t_r$	$I_C = 570\text{ mA}$	—	6	—	—	6	—	ns
Fall Time (See Test Ckt. Fig. 6), $t_f$	$I_{B1} = 30\text{ mA}$	—	100	—	—	100	—	ns
Delay Time (See Test Ckt. Fig. 6), $t_d$	$I_{B2} = 0$	—	7.5	—	—	7.5	—	ns
Storage Time (See Test Ckt. Fig. 6), $t_s$		—	850	—	—	850	—	ns

\*Pulse Conditions width = 300  $\mu\text{s}$ , duty cycle = 1%.

Arrays

CA3138, CA3138A

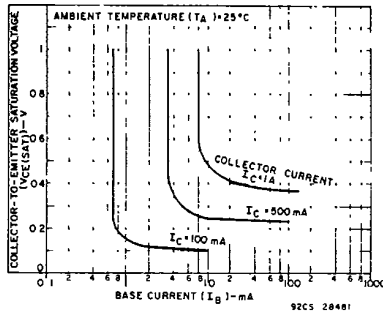


Fig. 2 -  $V_{CE}(sat)$  vs  $I_B$

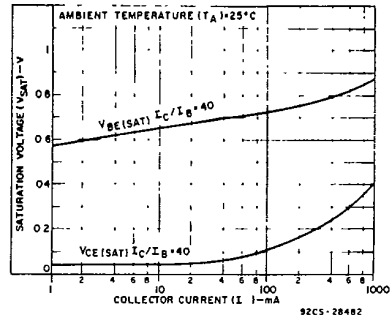


Fig. 3 -  $V_{sat}$  vs  $I_C$

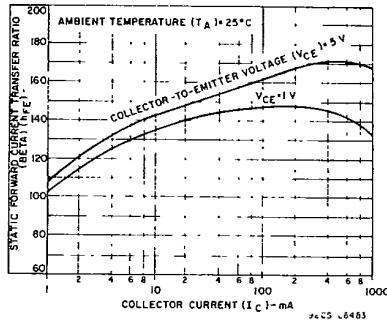


Fig. 4 -  $h_{FE}$  vs  $I_C$

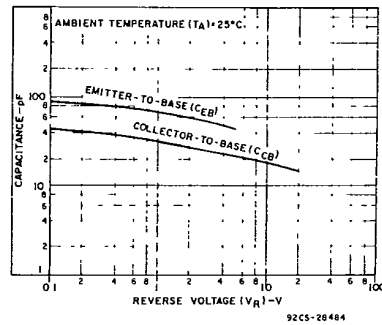


Fig. 5 -  $C_{CB}, C_{CE}$  vs  $V_R$

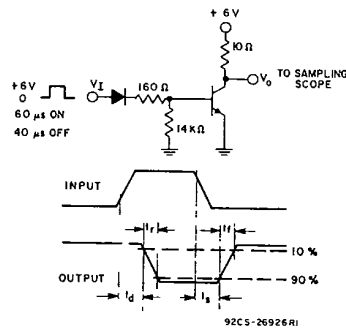


Fig. 6 - Switching time test circuit and waveforms.